The Challenge of Innovation in E-Waste Recycling:  
The Experiences of AER Worldwide  
at the  
Burke Auditorium, 195 Prospect St. New Haven CT  
Lecture 4:30-5:30PM, April 6, 2010  
Free and Open to the Public, Reception to Follow

Sponsored by the Industrial Environmental Management Program  
Yale School of Forestry and Environmental Studies

AER Worldwide’s Director of Business Development, Thomas Hogye, will speak at the Yale University School of Forestry & Environmental Studies on Tuesday, April 6th, at 4.30 p.m. in the Burke Auditorium, 195 Prospect St. His talk, entitled “The Challenge of Innovation in E-waste Recycling: The Experiences of AER Worldwide” is sponsored by the Industrial Environmental Management (IEM) Program.

The talk is part of the 2009/2010 IEM Speaker Series sponsored by the Yale IEM Program. In its 20th year, the IEM Lecture Series brings speakers from companies and organizations to the Yale School of Forestry & Environmental Studies to discuss the relationship between business and the environment. This year’s lecture series explores innovative uses of waste and recycling.

Since 1996, AER Worldwide has functioned as an independent distributor of integrated circuits with a focus on obtaining new and used excess and obsolete circuits. It also demanufactures and recycles end-of-life electronic products. Tracking, reporting and auditing of material movement downstream is also a key component of the company’s activities.

Mr. Hogye has ten years of experience in the recovery of electronics for effective reuse and recycling. He is also well versed in the processes of metals and materials recovery related to secondary smelting and refining practices. Mr. Hogye directed some of the largest electronics recycling events in the state of California and has developed long-term comprehensive recycling plans for major original equipment manufacturers, municipalities and other organizations. Mr. Hogye currently serves as a U.S. Industry Expert on electronics recycling for National Electrical Manufacturers Association (NEMA) and the International Electrotechnical Commission.

The IEM Lecture Series is supported by the Joel Omura Kurihara Fund. For more information about the lecture series, please contact Melanie Quigley, program coordinator, at 203.432.6953 or Melanie.quigley@yale.edu.

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